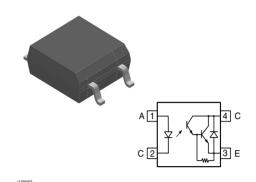


Vishay Semiconductors

Photodarlington Optocoupler, High BV_{CEO} Voltage Miniflat SOP Package

Features

- SOP (Small Outline Package)
- Isolation Test Voltage, 3750 V_{RMS} (1.0 s)
- High Collector-Emitter Breakdown Voltage, V_{CEO} = 300 V
- Low Saturation Voltage
- · Fast Switching Times
- Temperature Stable
- Low Coupling capacitance
- End-Stackable, .100 " (2.54 mm) Spacing



Agency Approvals

• UL - File No. E52744

Applications

High density mounting or space sensitive PCBs PLCs

Telecommunication

Description

The SFH692AT has a GaAs infrared emitting diode emitter, which is optically coupled to silicon planar phototransistor detector, and is incorporated in a 4 pin 100 mil lead pitch miniflat package. It features a high current transfer ratio, low coupling capacitance, and high isolation voltage.

The coupling devices are designed for signal transmission between two electrically separated circuits.

The SFH692AT is available only on tape and reel.

Order Information

Part	Remarks
SFH692AT	CTR > 1000 %, SMD

For additional order information see Option Section

Absolute Maximum Ratings

 $T_{amb} = 25$ °C, unless otherwise specified

Stresses in excess of the absolute Maximum Ratings can cause permanent damage to the devise. Functional operation of the device is not implied at these or any other conditions in excess of those given in the operational sections of this document. Exposure to absolute Maximum Rating for extended periods of the time can adversely affect reliability.

Emitter

Parameter	Test condition	Symbol	Value	Unit
DC Forward current		I _F	50	mA
Reverse voltage		V _R	6.0	V
Surge Forward current	t _p ≤ 10 μs	I _{FSM}	2.5	A
Total power dissipation		P _{Diss}	80	mW

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Detector

Parameter	Test condition	Symbol	Value	Unit
Collector-emitter voltage		V _{CE}	300	V
Emitter-collector voltage		V _{EC}	0.3	V
Collector current		I _C	50	mA
	$t_p \le 1.0 \text{ ms}$	I _C	150	mA
Total power dissipation		P _{Diss}	200	mW

Coupler

Parameter	Test condition	Symbol	Value	Unit
Isolation test voltage between emitter and detector, (1.0 s)		V _{IO}	3750	V _{RMS}
Creepage			≥ 5.0	mm
Clearance			≥ 5.5	mm
Comparative tracking index per DIN IEC 112/VDEO 303, part 1			≥ 175	
Isolation resistance	$V_{IO} = 500 \text{ V}, T_{amb} = 25 ^{\circ}\text{C}$	R _{IO}	≥ 10 ¹²	Ω
	V _{IO} = 500 V, T _{amb} = 100 °C	R _{IO}	≥ 10 ¹¹	Ω
Storage temperature range		T _{stg}	- 55 to + 150	°C
Ambient temperature range		T _{amb}	- 55 to + 100	°C
Junction temperature		T _j	100	°C
Soldering temperature (max. 10 s. dip soldering distance to seating plane ≥ 1.5 mm)		T _{sd}	260	°C

Electrical Characteristics

T_{amb} = 25 °C, unless otherwise specified
Minimum and maximum values are testing requirements. Typical values are characteristics of the device and are the result of engineering evaluation. Typical values are for information only and are not part of the testing requirements.

Emitter

Parameter	Test condition	Symbol	Min	Тур.	Max	Unit
Forward voltage	I _F = 10 mA	V _F		1.2	1.5	V
Reverse current	V _R = 6.0 V	I _R		0.01	10	μΑ
Capacitance	V _R = 0 V, f = 1.0 MHz	Co		14		pF
Thermal resistance		R _{thJA}		750		K/W

Detector

Parameter	Test condition	Symbol	Min	Тур.	Max	Unit
Collector-emitter leakage current	V _{CE} = 200 V	I _{CEO}			200	nA
Capacitance	V _{CE} = 5.0 V, f = 1.0 MHz	C _{CE}		39		pF
Thermal resistance		R _{thJA}		500		K/W



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Coupler

Parameter	Test condition	Symbol	Min	Тур.	Max	Unit
Collector-emitter saturation voltage	$I_F = 1.0 \text{ mA}, I_C = 10 \text{ mA}$	V _{CEsat}			1.0	V
	$I_F = 10 \text{ mA}, I_C = 100 \text{ mA}$	V _{CEsat}	0.3		1.2	V
Coupling capacitance	f = 1.0 MHz, V _{I-O} = 0 V	C _C		0.6		pF

Current Transfer Ratio

Parameter	Test condition	Symbol	Min	Тур.	Max	Unit
Current transfer ratio	$I_F = 1.0 \text{ mA}, V_{CE} = 1.0 \text{ V}$	CTR	1000			%
Saturated CTR	I _F = 10 mA, V _{CE} = 1.0 V	CTR _{SAT}	500			%

Switching Characteristics

Parameter	Test condition	Symbol	Min	Тур.	Max	Unit
Rise time	$I_F = 10.0 \text{ mA}, V_{CC} = 10.0 \text{ V},$ $R_L = 100 \Omega$	t _r			3.5	μs
	$I_F = 16.0 \text{ mA}, V_{CC} = 10.0 \text{ V},$ $R_L = 180 \Omega$	t _r		1.0		μs
Fall time	$I_F = 10.0 \text{ mA}, V_{CC} = 10.0 \text{ V},$ $R_L = 100 \Omega$	t _f			14.5	μs
	$I_F = 16.0 \text{ mA}, V_{CC} = 10.0 \text{ V},$ $R_L = 180 \Omega$	t _f		20.5		μs
Turn-on time	I_F = 10.0 mA, V_{CC} = 10.0 V, R_L =100 Ω	t _{on}			4.5	μs
	I_F = 16.0 mA, V_{CC} = 10.0 V, R_L = 180 $Ω$	t _{on}		1.5		μs
Turn-off time	I_F = 10.0 mA, V_{CC} = 10.0 V, R_L =100 Ω	t _{off}			29.0	μs
	I_F = 16.0 mA, V_{CC} = 10.0 V, R_L = 180 Ω	t _{off}		53.5		μs

Typical Characteristics ($T_{amb} = 25$ °C unless otherwise specified)

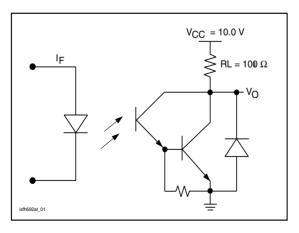


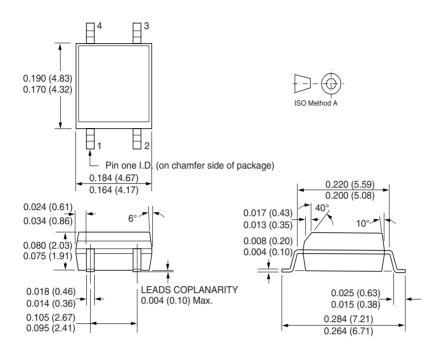
Figure 1. Linear Operation (without saturation)

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Package Dimensions in Inches (mm)



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Ozone Depleting Substances Policy Statement

It is the policy of Vishay Semiconductor GmbH to

- 1. Meet all present and future national and international statutory requirements.
- 2. Regularly and continuously improve the performance of our products, processes, distribution and operatingsystems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

Vishay Semiconductor GmbH has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

- 1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
- 2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
- 3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

Vishay Semiconductor GmbH can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes to improve technical design and may do so without further notice.

Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use Vishay Semiconductors products for any unintended or unauthorized application, the buyer shall indemnify Vishay Semiconductors against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

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